

# Industry Partnerships with Florida's c-Si PVMC

Cocoa, FL – Oct 23<sup>rd</sup>, 2015

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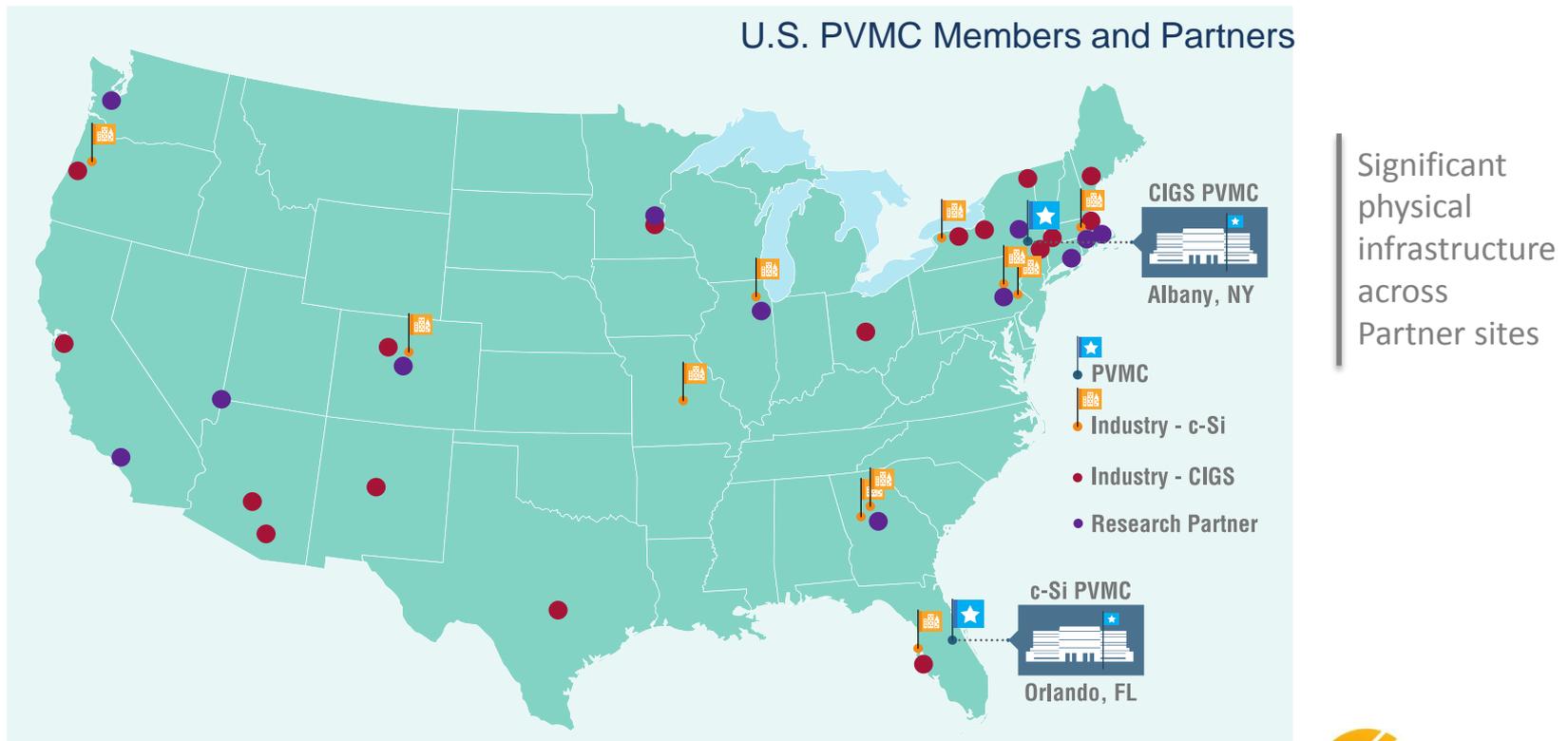
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**Dr. Paul Brooker** – *FSEC Asst. Research Professor*

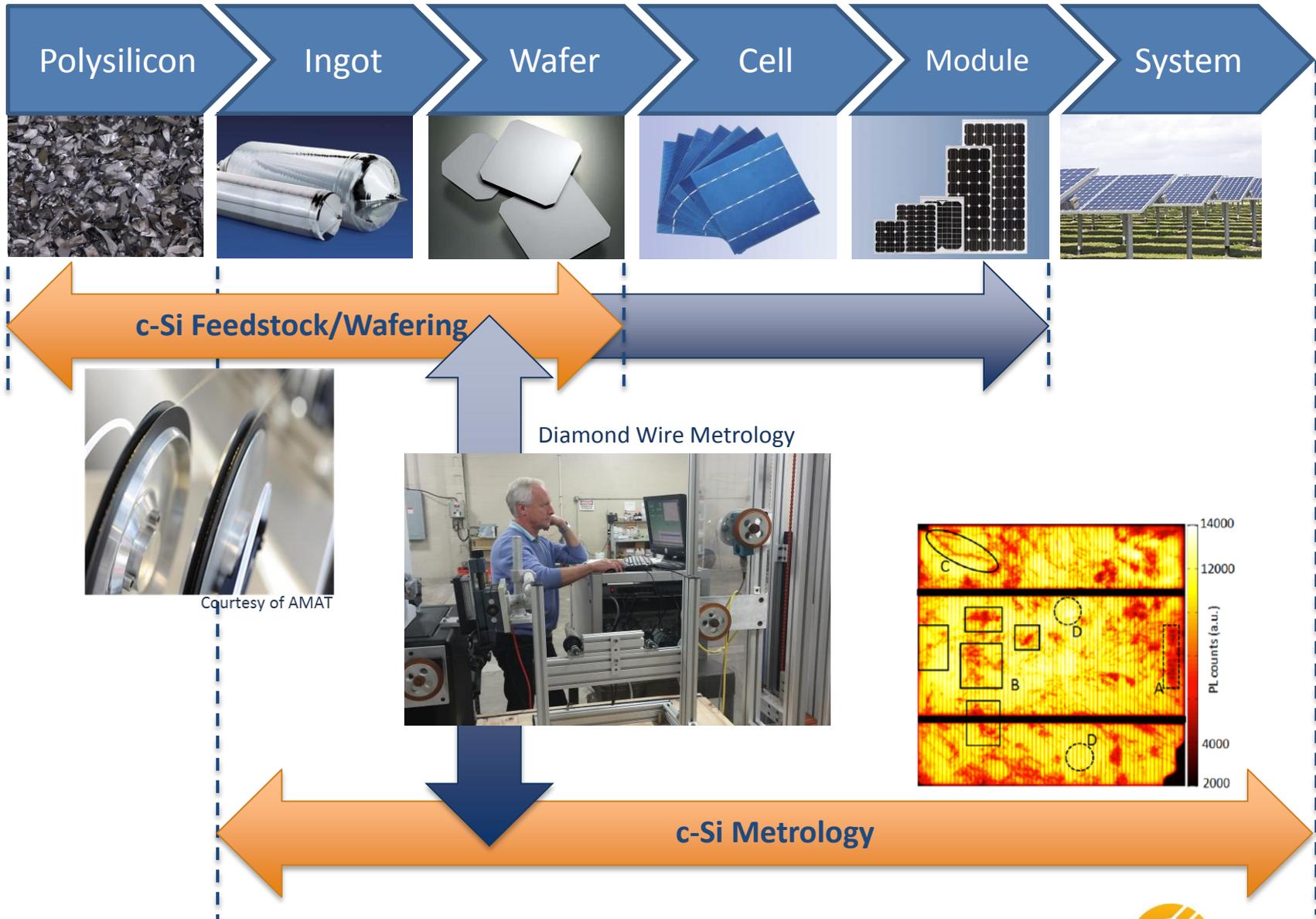


# U.S. Photovoltaic Manufacturing Consortium (PVMC)

- Industry-led Consortium, funded by DOE SunShot Initiative
- Two Technology Areas: CIGS/Lightweight PV + c-Si PV
- Broad network of industrial members and partners (60+)



# Initial Florida c-Si PVMC Program Areas



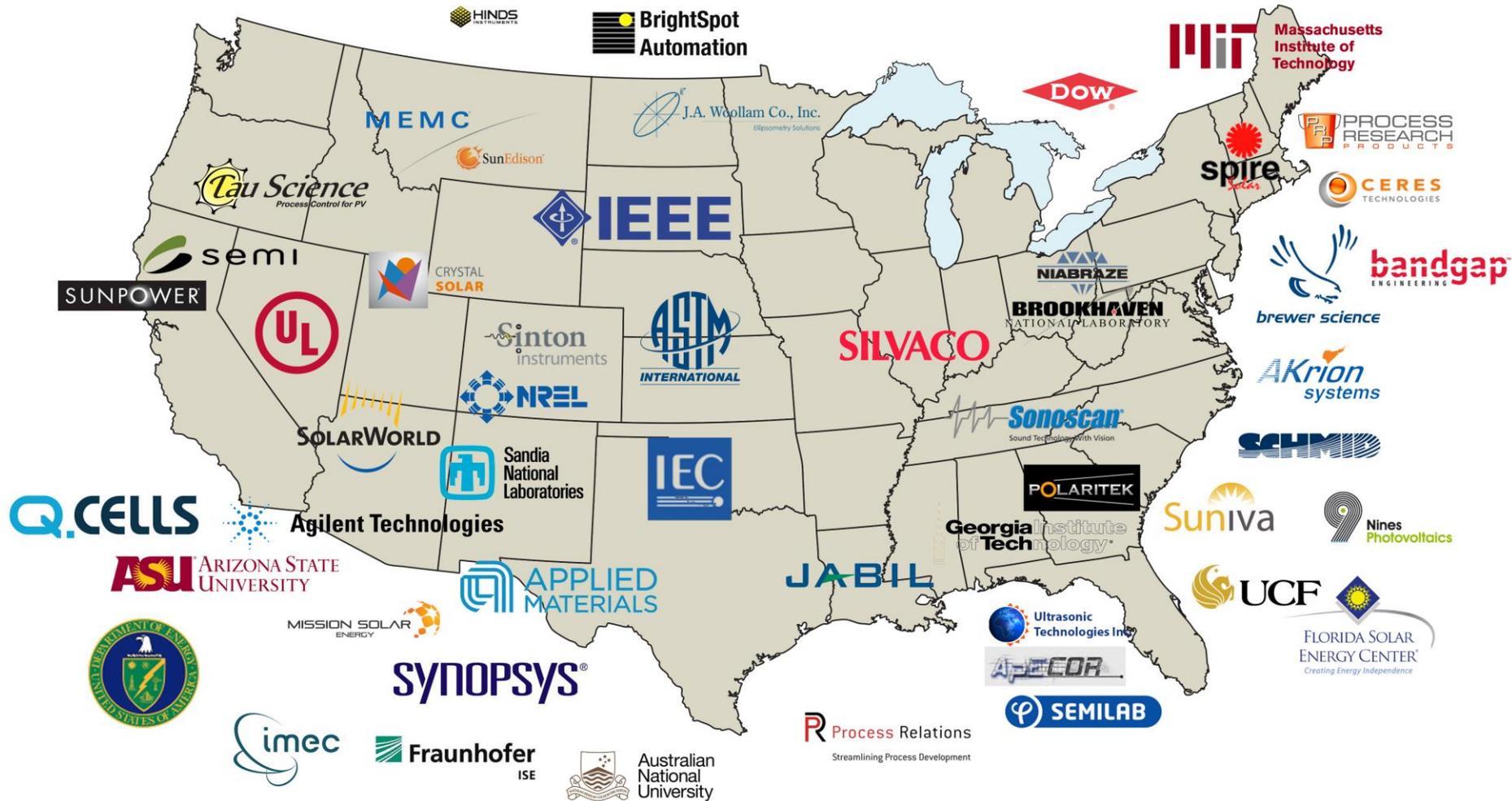
# c-Si PVMC Industrial Membership

- Current c-Si PVMC Members



- However, the c-Si PVMC projects involve a much larger network of collaborators...

# Map of c-Si PVMC Participants (*Members and Collaborators*)

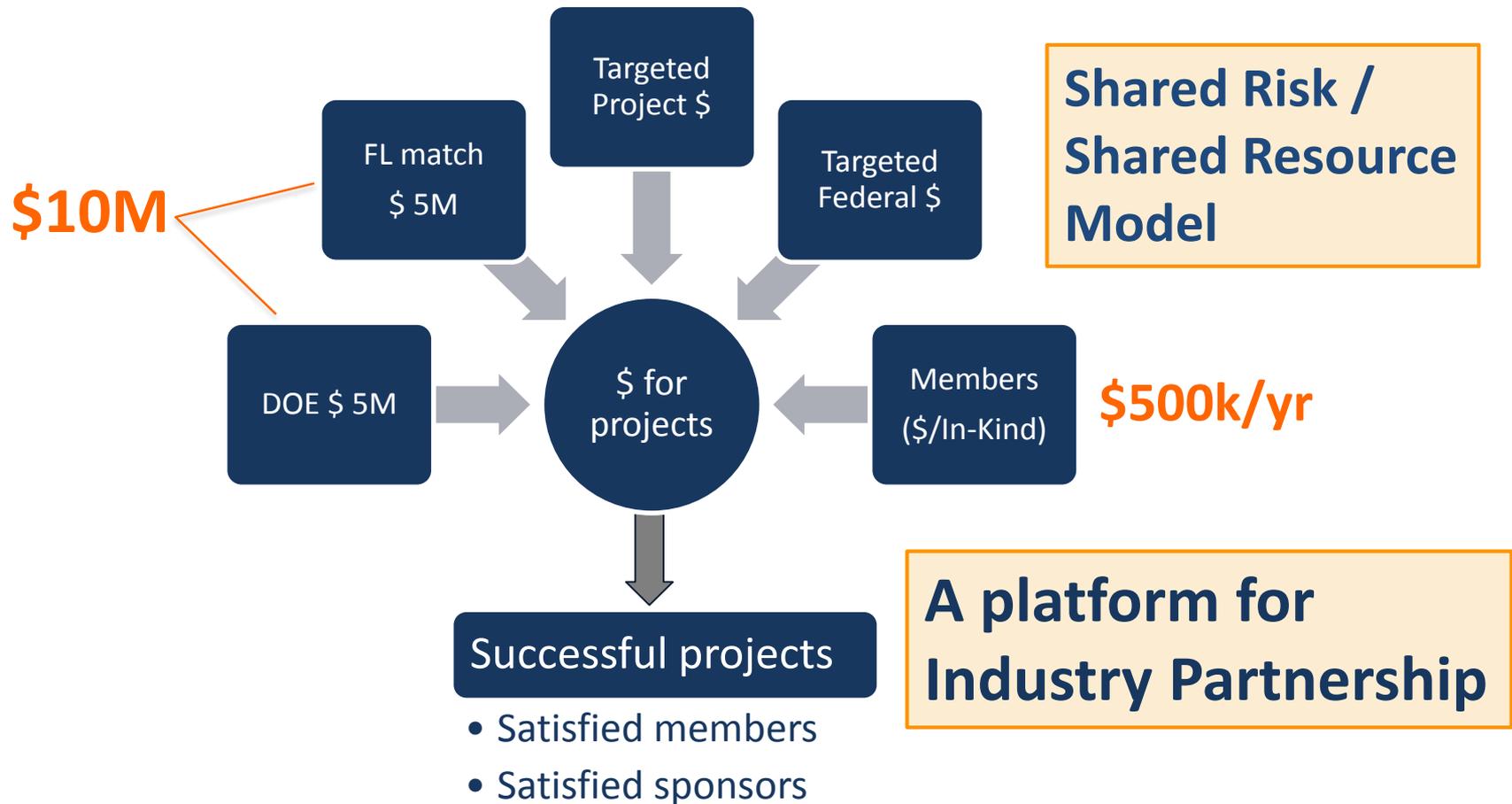


One of the most powerful distributed networks of infrastructure in solar



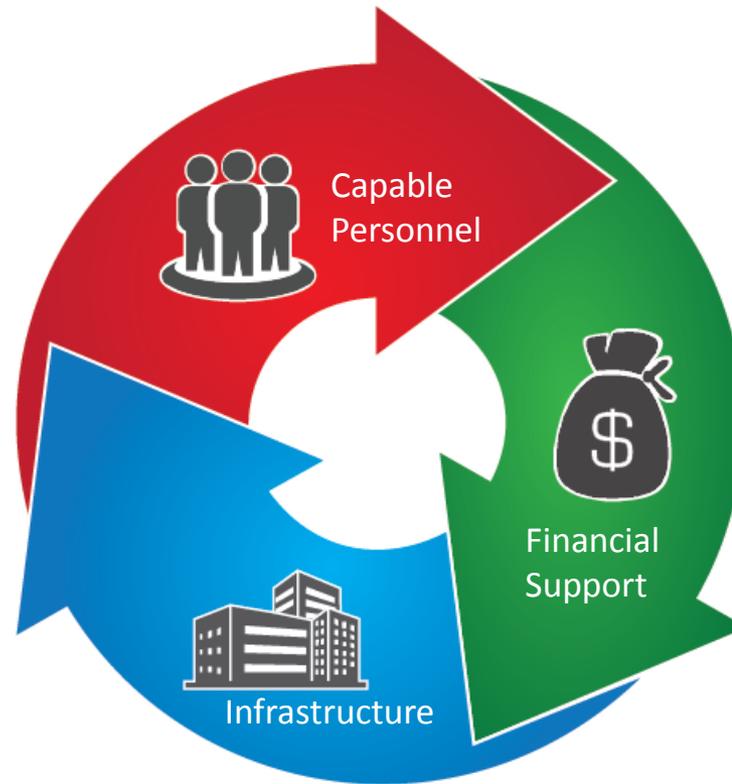
# c-Si PVMC Funding

- Current funding to October 2017 ( ~\$2M / Year)



# Direct Impacts of Industry Partnership to FSEC / UCF

- Requirements of Impactful RD&D



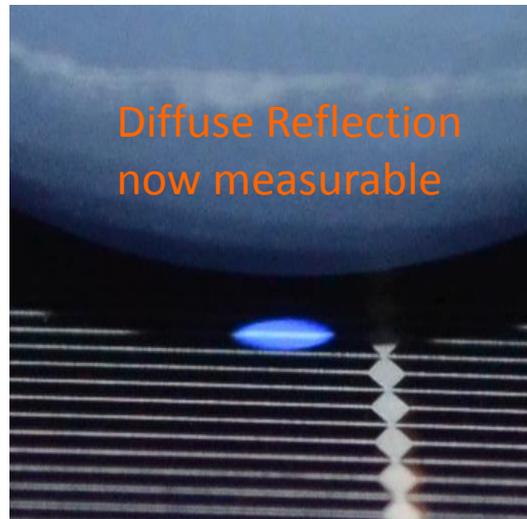
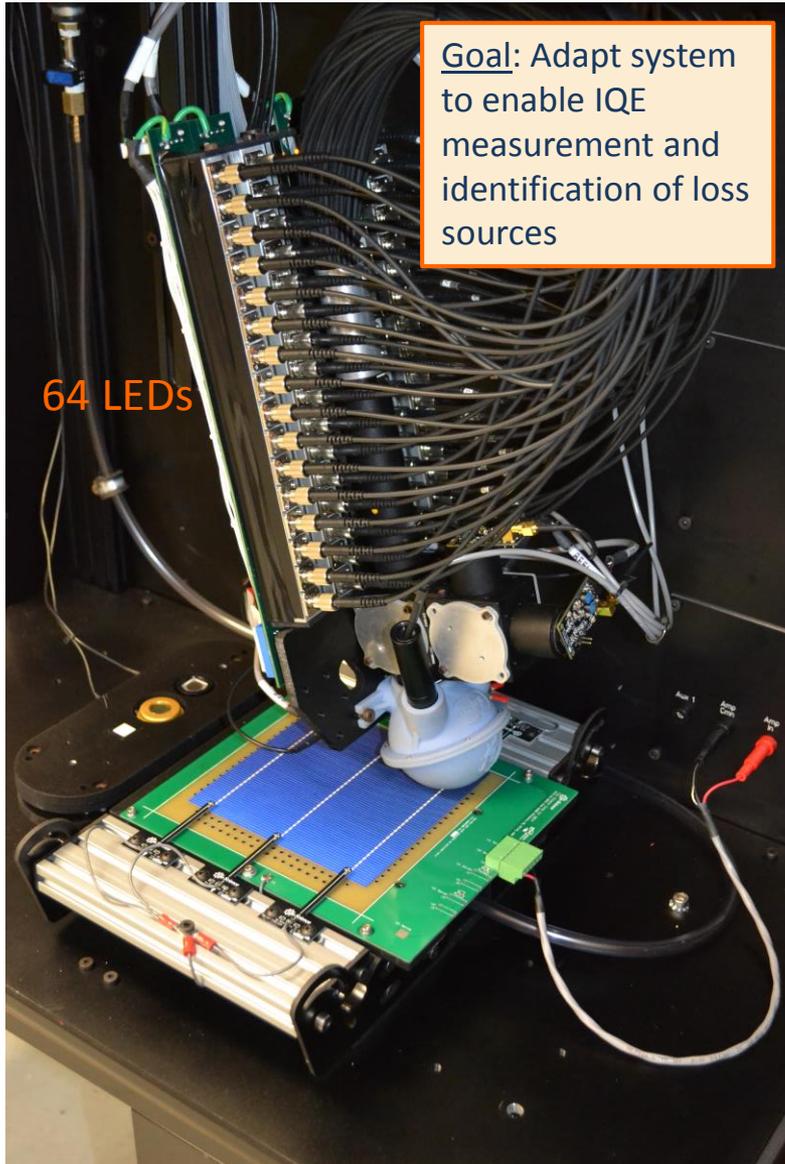
- Industry Partnership can provide each of these...particularly infrastructure ... but it must be reciprocal.

# c-Si PVMC Collaborative Consortium Projects

Some examples of **Successful Industry Partnership...**

# Example #1: Customized FlashQE with Integrating Sphere

Challenge: Existing fast QE system, **but limited value to manufacturers**



Spot Size:  $\approx 3.5-4.0$  mm



**Impact:**

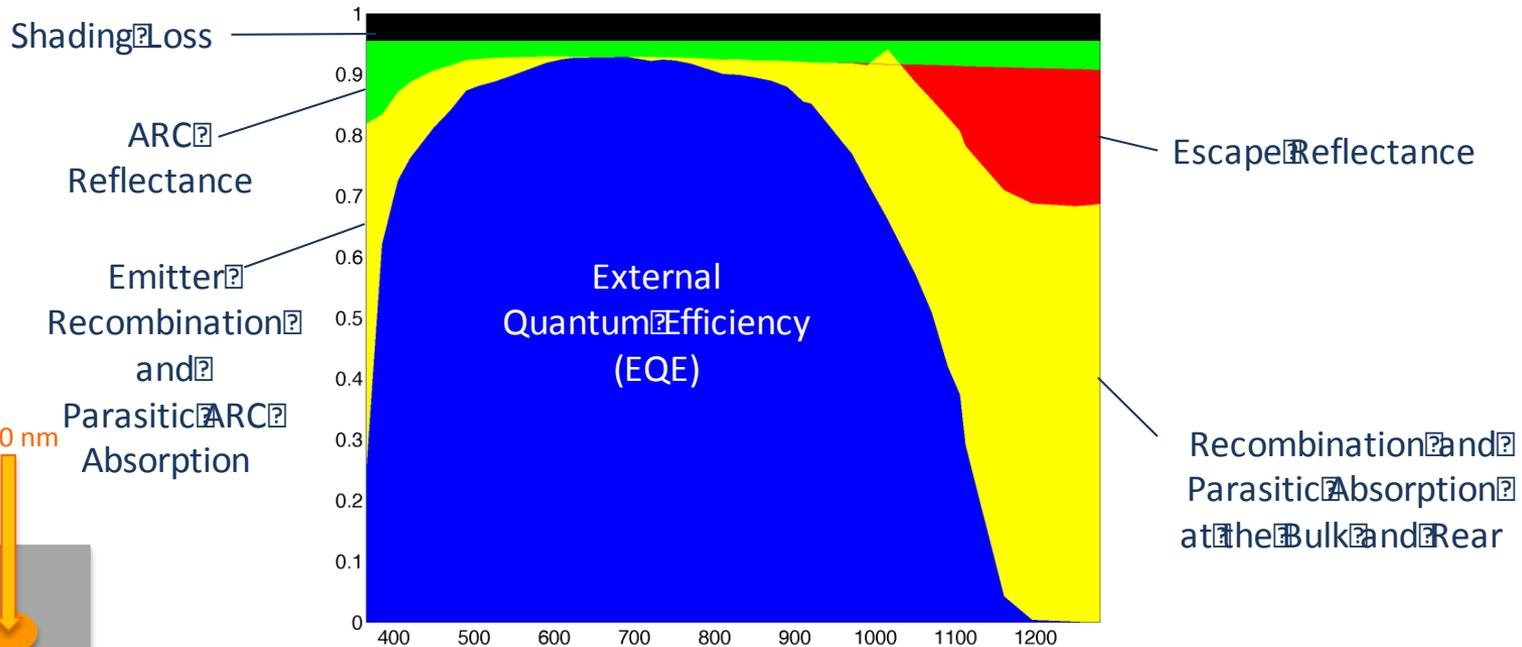
IQE and QE measurement in **1sec** rather than 30min



# Identifying Where the Problem Occurs in Manufacturing

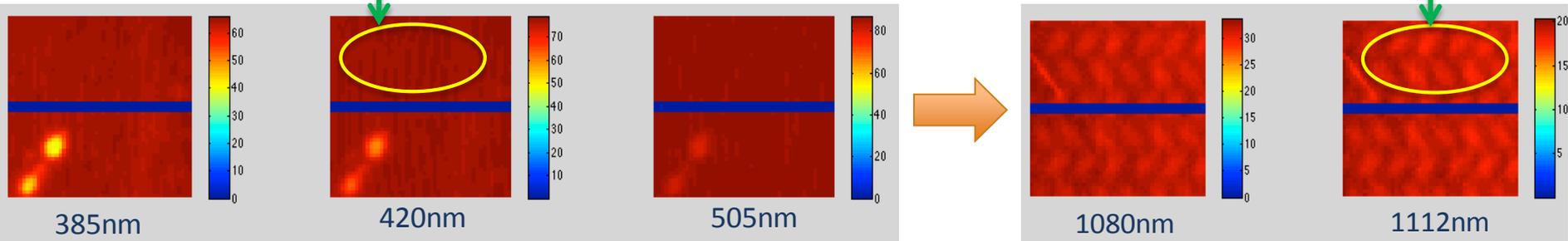
Front of the Cell

Bulk/Rear of the Cell



Front of the Cell

Rear of the Cell

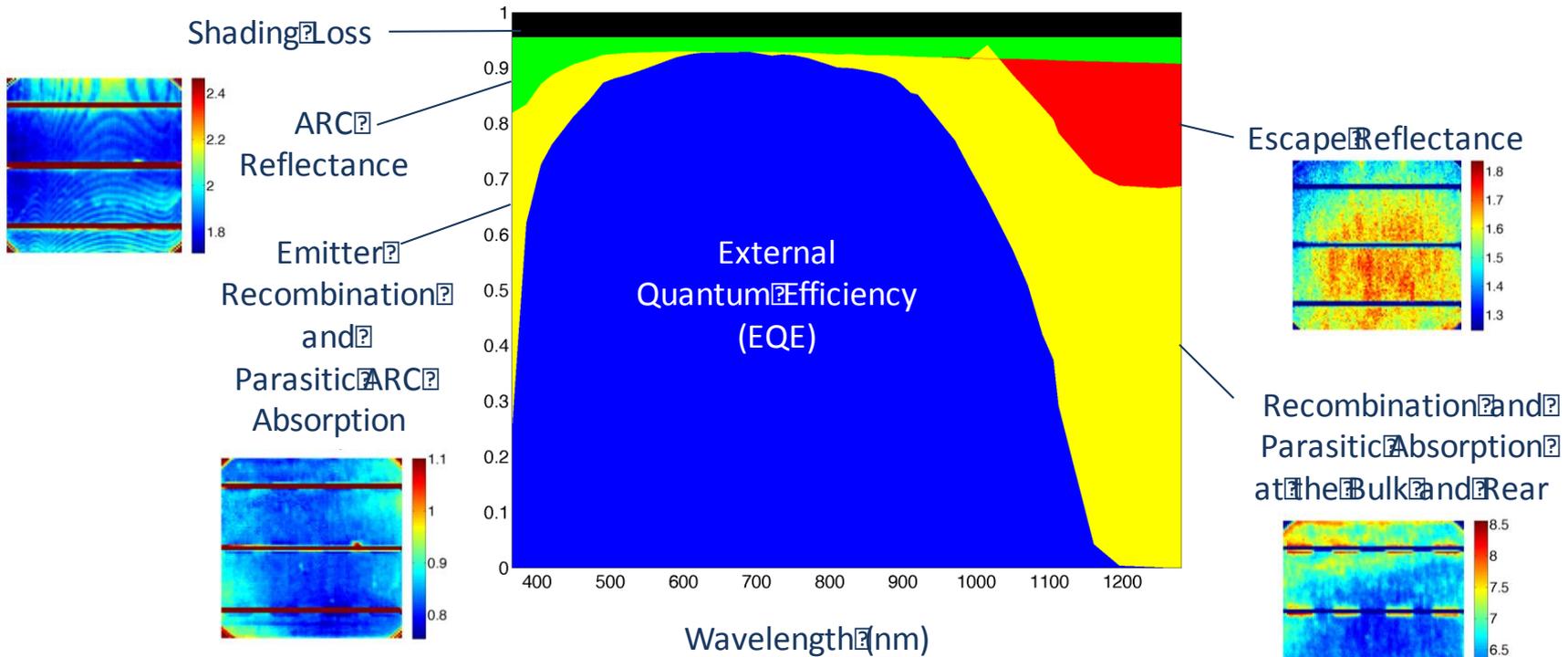


**Impact:** First demonstration of correlation between QE and cell location for losses

# Decoupling and Quantifying Current Loss (Why it happened)

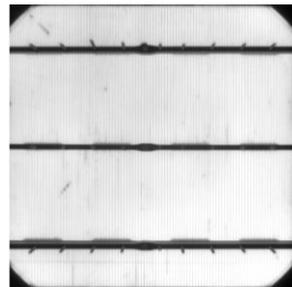
Front of the Cell

Bulk/Rear of the Cell

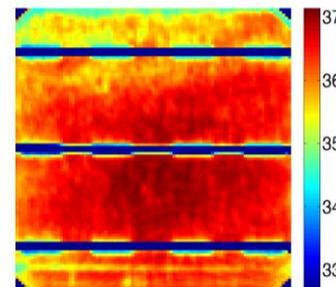


## Current Work:

We (FSEC) developed software that now converts raw data quickly into spatially resolved maps of loss mechanisms

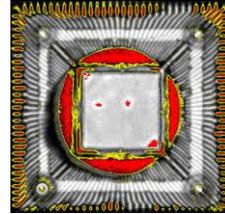


EL Image

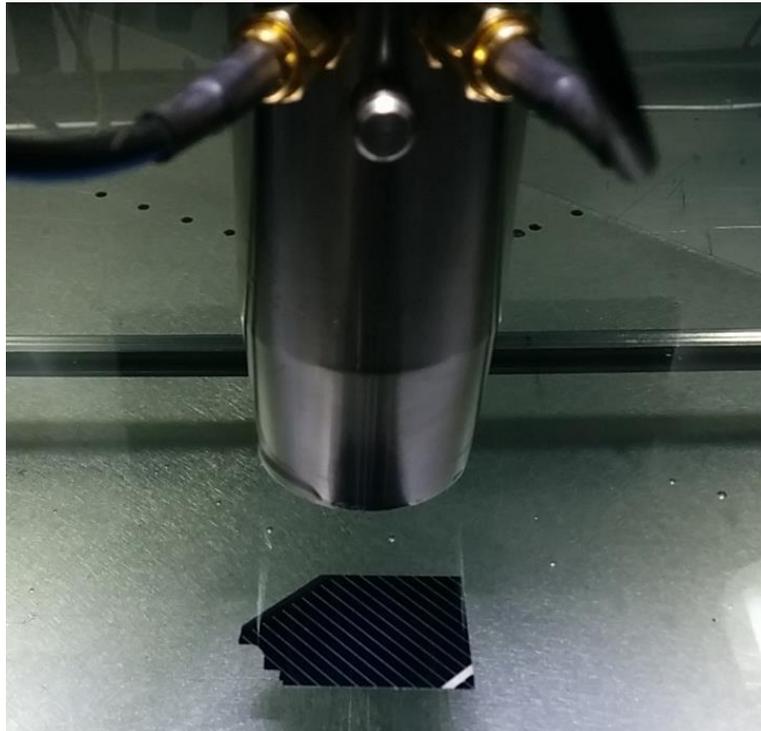


$J_{sc}$  from EQE

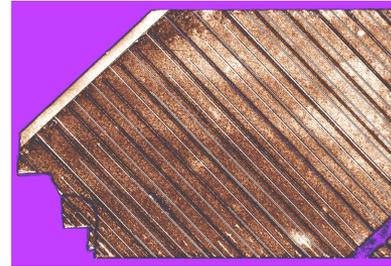
# Example #2: Void Detection Using Scanning Acoustic Microscopy (SAM)



Existing SAM Tool at Sonoscan



Interface Scan



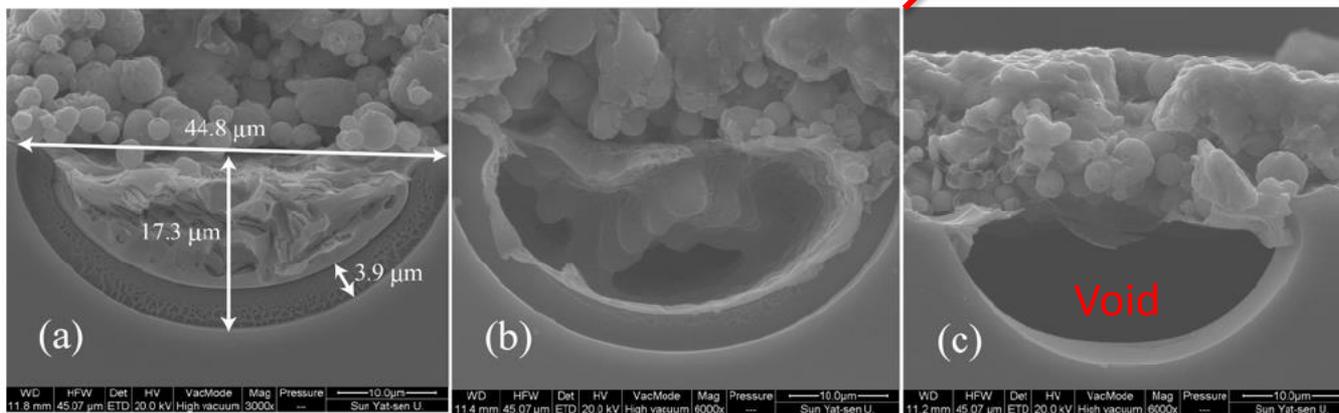
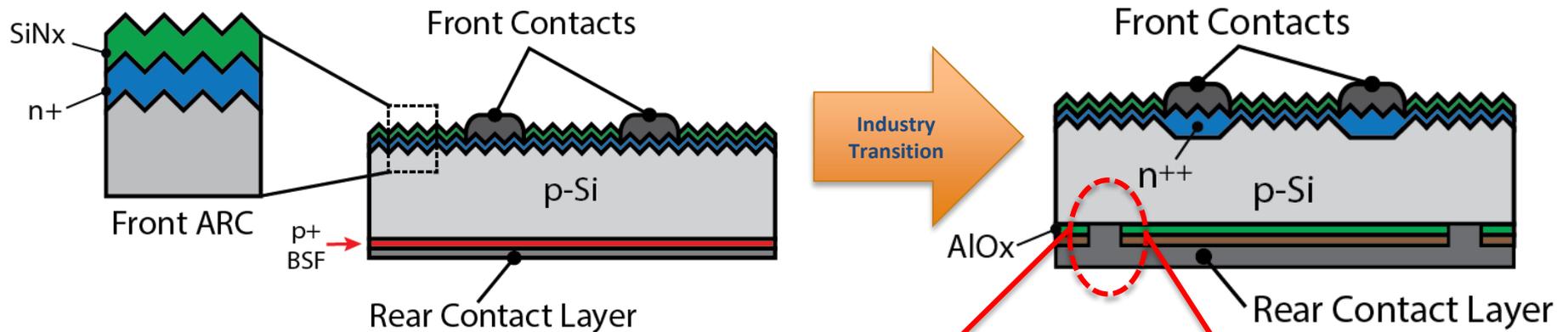
THRU Scan



- Sonoscan, established in semiconductor market, interested in entering Solar market
- Not successful in finding the appropriate application
- We identified void detection and believed SAM might be solution

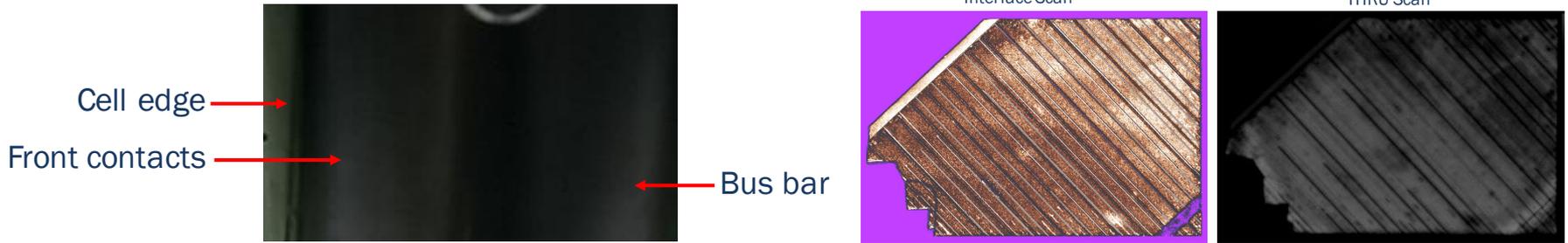
# Voids in p-PERC PV Cells - a Major Challenge

- Industry Issue:** Voids in PERC cells – How to Detect???



Yifeng C, et al., 40th IEEE PVSC, Denver, CO, 2014.

# Void Detection Using Scanning Acoustic Microscopy



- Outcomes:**
- Identified potential use for SAM
  - Arranged unique p-PERC cell sample set
  - Developed high speed method for void detection
  - Currently developing an automated process for determining void fraction in manufacturing

# Example #3: High throughput bonding /debonding process for fabricating thin silicon PV cells



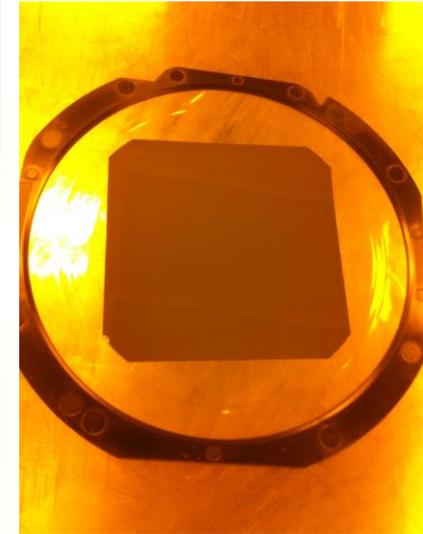
Top side after BSI.T13091A coating



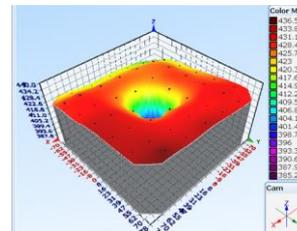
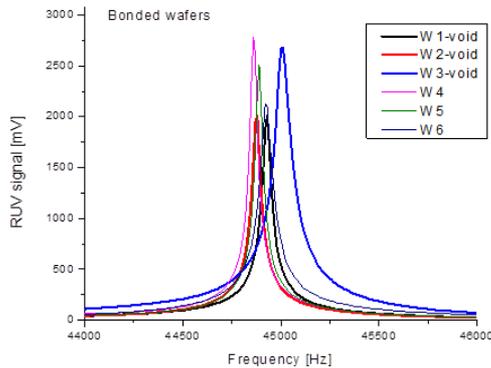
After bonding



After lamination



After separation

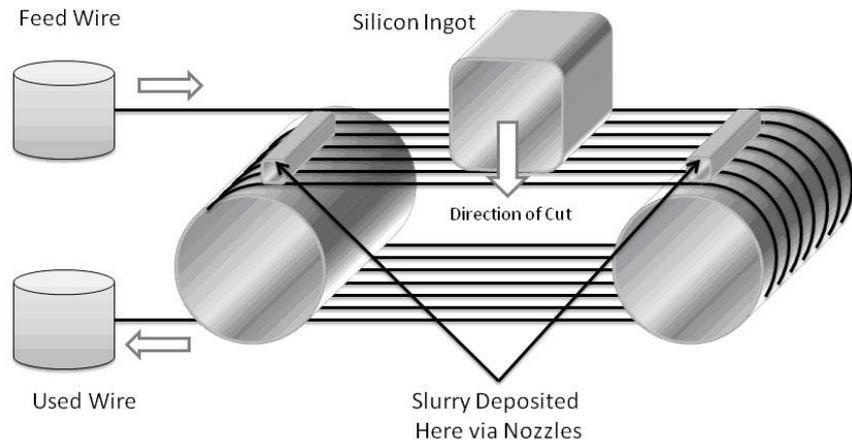


## Outcomes:

1. Validation of process compatibility
2. Identified cost requirement and determined it was not feasible

# Example 4: In-line Diamond Wire Metrology

- Diamond Wire wafering is growing in market share



- Challenge: There is no robust method to monitor wear, leading to significant yield loss (as high as 30%)
- The value of a consortium...

Slurry/Lubricant Manufacturer



Diamond Wire Manufacturer



Question: Can this be applied to diamond wire

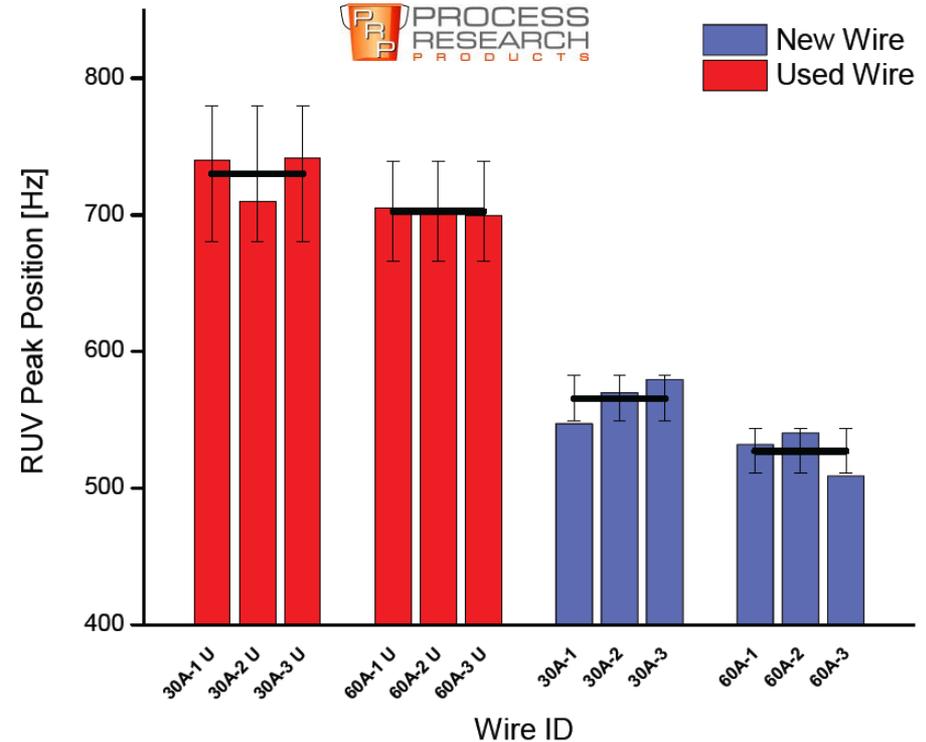
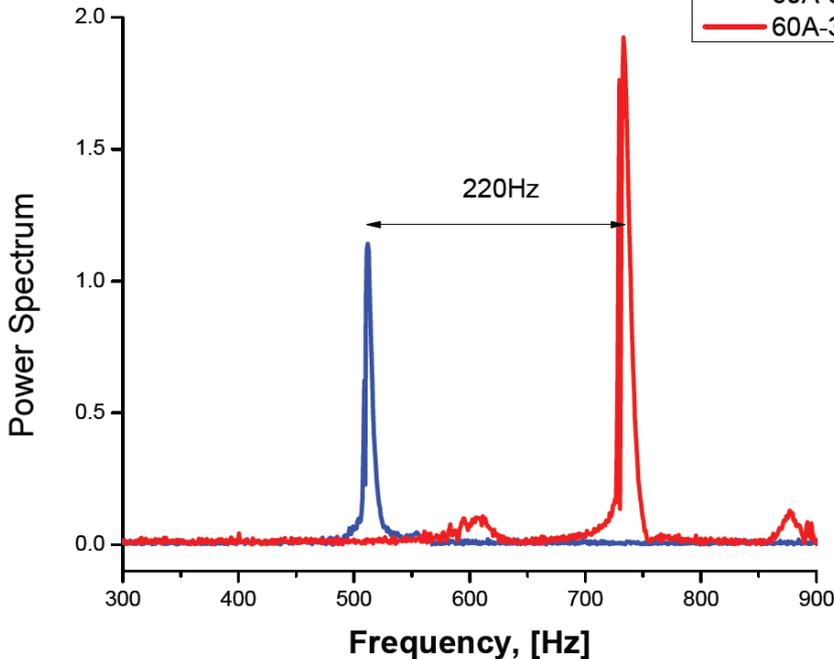
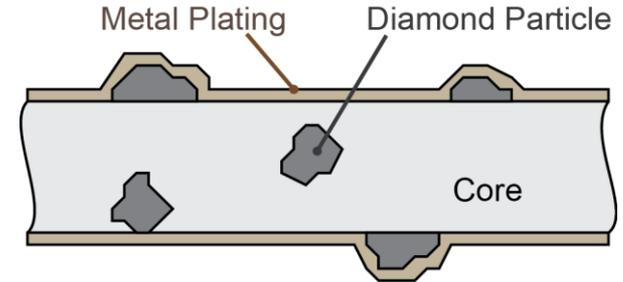
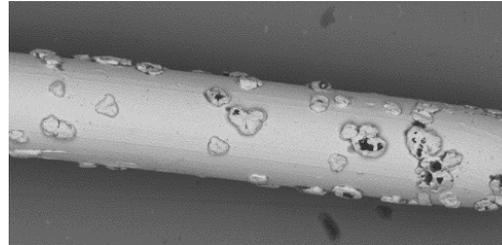
Crack Detection Metrology



Ultrasonic  
Technologies, Inc.

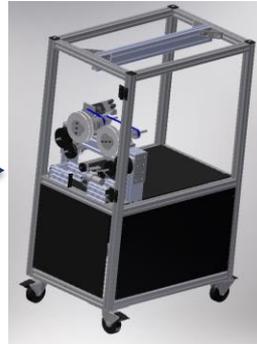
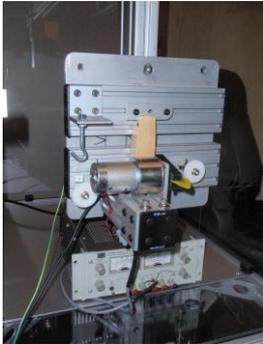
# Step 1: Can it detect wire wear?

Gen 1: Static Prototype



# Step 2: Validate with Moving Diamond Wire

## Generation 1.0 (Static)



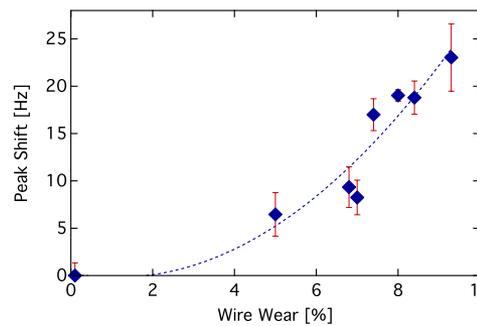
## Generation 2.0 (Dynamic)



National Renewable Energy Laboratory  
Innovation for Our Energy Future

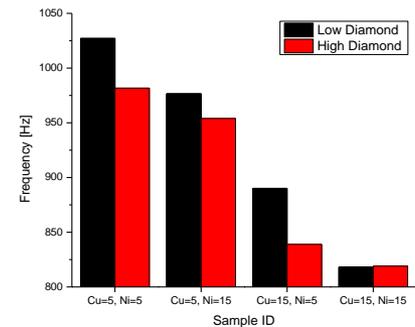
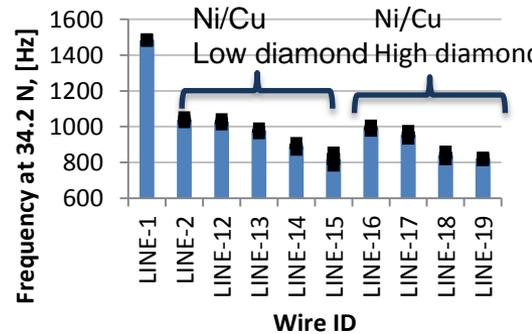


### Diamond wire wear monitoring (Sawing)



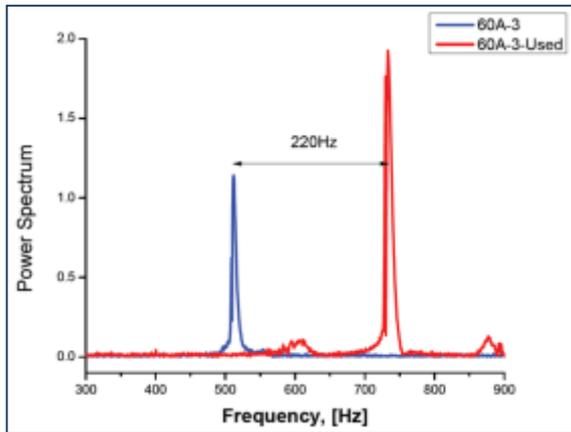
Failure is at 11%

### Quality control (DW manufacturing)



# Step 3: Integration into Pilot Line

Proof of Concept (August 2013)



Prototype I: Stationary wire  
(November 2013)



Prototype II: Moving wire  
(July 2014)

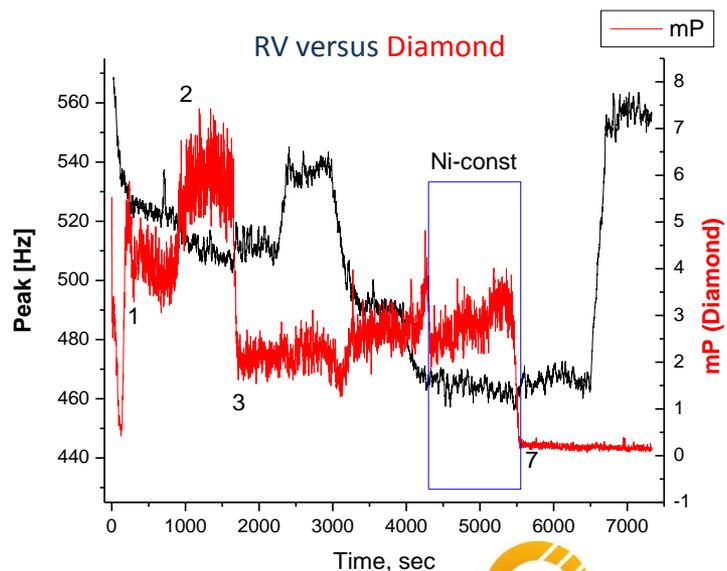
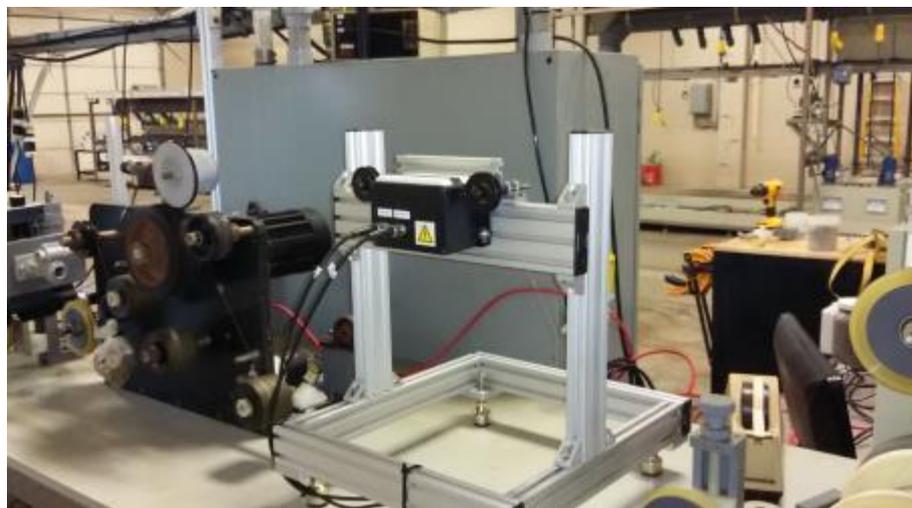
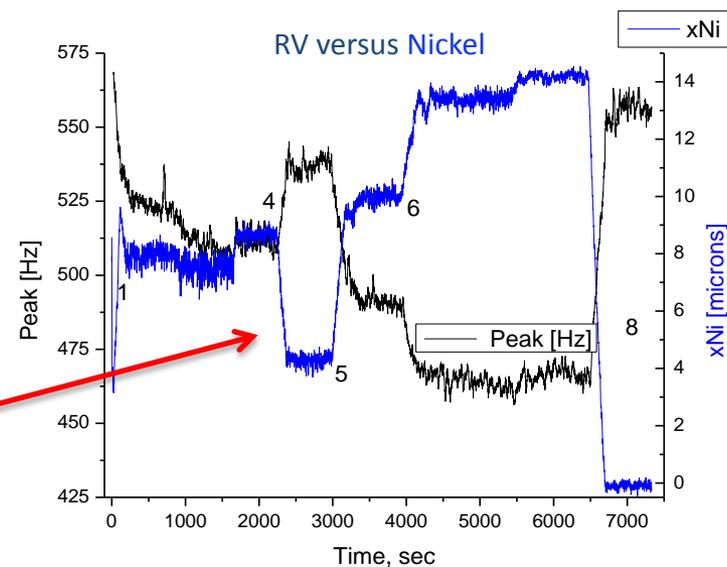


Prototype III: Portable, non-contact sensor  
(July 2015)

Industrial Partnerships allowed us to transition from TRL level 1 to 7



# Field validation of inline tool on a DW pilot line



# Other Notable FSEC Partnerships



BTi LIS-R1



- PL system in their R&D line
- Regular visits to run experiments
- Remote measurement capability
- Considerable joint proposal activity



FSEC Researcher regular multi-week stays in their World class R&D Pilot Line over 2.5 years

Jointly developed APCVD passivation technologies

- 4 peer-reviewed journal publications
- 3 invited presentations
- 2 patent applications



Plan to have FSEC graduate student working at IMEC on joint project for 6 months starting in January



Just began collaboration on passivated contacts.

Submitted joint proposal to DOE in collaboration with Suniva.



# Parting Comments and Thoughts

- Industry Partnership has enabled significant advancement of FSEC/UCF as **a recognized leader in PV Research**  
Diamond Wire Wafering / Predictive Metrology / Advanced Passivation
- Must identify top needs and challenges of Industry
- c-Si PVMC Projects have allowed FSEC/UCF to engage industry much like dating
- Demonstrating hard work and direct value to industry **leads to deeper partnerships and strong trust**
- **Valuable model** to expand into other program areas
- Advisory Board can help FSEC identify areas where model can be applied effectively and perhaps create initial connection to Industry